Se	arcn Notes
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/626,209	DEVOE	
Examiner	Art Unit	
Krishnan S. Menon	1723	

	SEAR	CHED	
Class	Subclass	Date	Examiner
	- 111. 211.		
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	<u> </u>		

SEARCH NO (INCLUDING SEARCI		<u>).</u>
	DATE	EXMR
Inventor search	10/15/2005	KM
210/649,652,321.66 60/639,641.8,641.15,530,512,645 290/54 word search	10/15/2005	KM
update	4/22/2006	
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